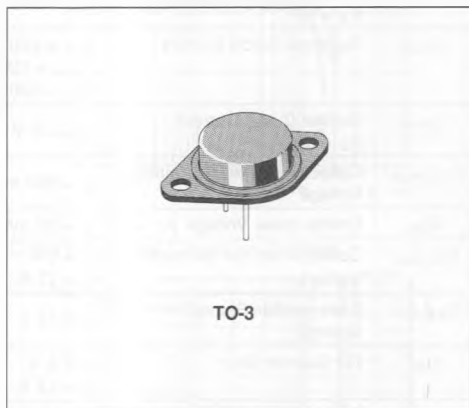


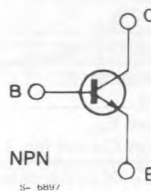
## HIGH CURRENT, HIGH SPEED, HIGH POWER TRANSISTOR

### DESCRIPTION

The BUX41N is a silicon multiepitaxial planar NPN transistor in Jedec TO-3 metal case, intended for use in switching and linear applications in military and industrial equipment.



### INTERNAL SCHEMATIC DIAGRAM



### ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-base Voltage ( $I_E = 0$ )	220	V
$V_{CEX}$	Collector-emitter Voltage ( $V_{BE} = -1.5$ V)	220	V
$V_{CEO}$	Collector-emitter Voltage ( $I_B = 0$ )	160	V
$V_{EBO}$	Emitter-base Voltage ( $I_C = 0$ )	7	V
$I_C$	Collector Current	18	A
$I_{CM}$	Collector Peak Current ( $t_p = 10$ ms)	25	A
$I_B$	Base Current	3.6	A
$P_{tot}$	Total Power Dissipation at $T_{case} \leq 25$ °C	120	W
$T_{stg}$	Storage Temperature	-65 to 200	°C
$T_j$	Junction Temperature	200	°C

**THERMAL DATA**

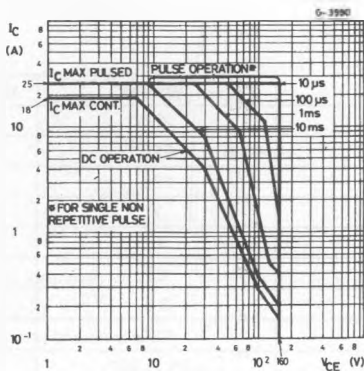
$R_{th\ j-case}$	Thermal Resistance Junction-case	Max	1.46	°C/W
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**ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25\text{ °C}$  unless otherwise specified)

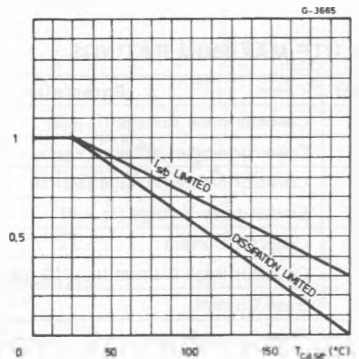
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$I_{CEO}$	Collector Cutoff Current ( $I_B = 0$ )	$V_{CE} = 130\text{ V}$			1	mA
$I_{CEX}$	Collector Cutoff Current	$V_{CE} = 220\text{ V}$ $V_{BE} = -1.5\text{ V}$ $T_{case} = 125\text{ °C}$ $V_{CE} = 220\text{ V}$ $V_{BE} = -1.5\text{ V}$			1 5	mA mA
$I_{EBO}$	Emitter Cutoff Current ( $I_C = 0$ )	$V_{EB} = 5\text{ V}$			1	mA
$V_{CEO(sus)}^*$	Collector-emitter Sustaining Voltage	$I_C = 200\text{ mA}$	160			V
$V_{EBO}$	Emitter-base Voltage ( $I_C = 0$ )	$I_E = 50\text{ mA}$	7			V
$V_{CE(sat)}^*$	Collector-emitter Saturation Voltage	$I_C = 8\text{ A}$ $I_B = 0.8\text{ A}$ $I_C = 12\text{ A}$ $I_B = 1.5\text{ A}$		0.5 0.75	1.2 1.6	V V
$V_{BE(sat)}^*$	Base-emitter Saturation Voltage	$I_C = 12\text{ A}$ $I_B = 1.5\text{ A}$		1.5	2	V
$h_{FE}^*$	DC Current Gain	$I_C = 8\text{ A}$ $V_{CE} = 4\text{ V}$ $I_C = 12\text{ A}$ $V_{CE} = 4\text{ V}$	15 8		45	
$I_{s/b}$	Second Breakdown Collector Current	$V_{CE} = 30\text{ V}$ $t = 1\text{ s}$ $V_{CE} = 100\text{ V}$ $t = 1\text{ s}$	4 0.27			A A
$f_T$	Transition Frequency	$I_C = 1\text{ A}$ $V_{CE} = 15\text{ V}$ $f = 10\text{ MHz}$	8			MHz
$t_{on}$	Turn-on Time (fig. 2)	$I_C = 12\text{ A}$ $I_{B1} = 1.5\text{ A}$ $V_{CC} = 30\text{ V}$		0.35	1.3	μs
$t_s$	Storage Time (fig. 2)	$I_C = 12\text{ A}$		0.85	1.5	μs
$t_f$	Fall Time (fig. 2)	$I_{B1} = -I_{B2} = 1.5\text{ A}$ $V_{CC} = 30\text{ V}$		0.14	0.8	μs
	Clamped $E_{s/b}$ Collector Current (fig. 1)	$V_{clamp} = 160\text{ V}$ $L = 500\text{ μH}$	12			A

\* Pulsed : pulse duration = 300 μs, duty cycle ≤ 2%.

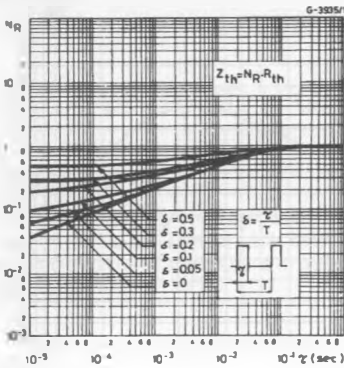
**Safe Operating Areas.**



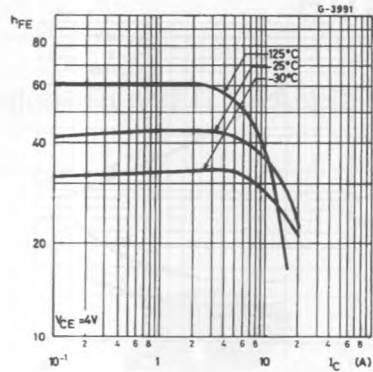
**Derating Curves.**



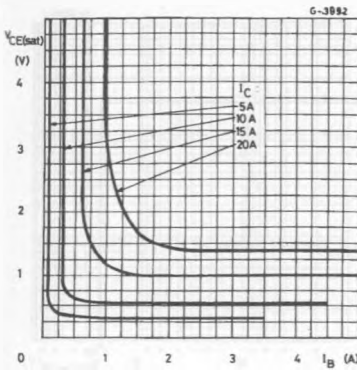
Thermal Transient Response.



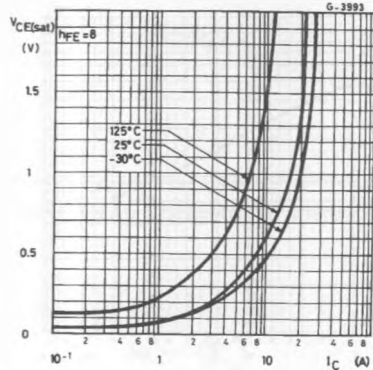
DC Current Gain.



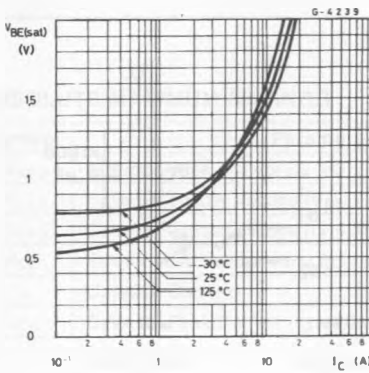
Collector-emitter Saturation Voltage.



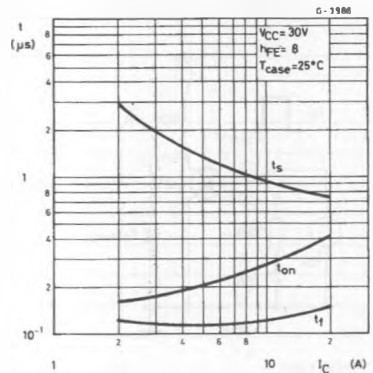
Collector-emitter Saturation Voltage.



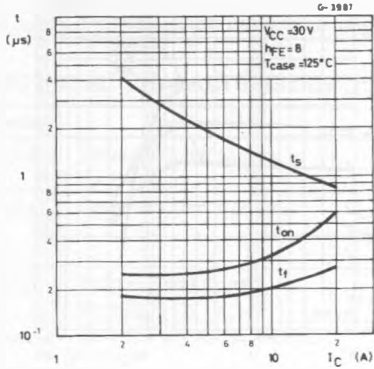
Base-emitter Saturation Voltage.



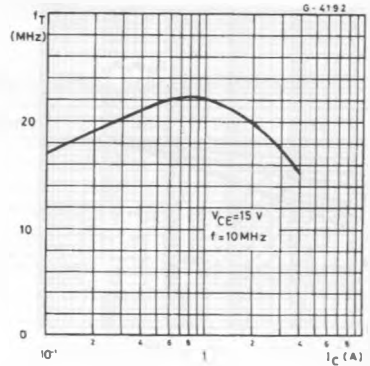
Saturated Switching Characteristics.



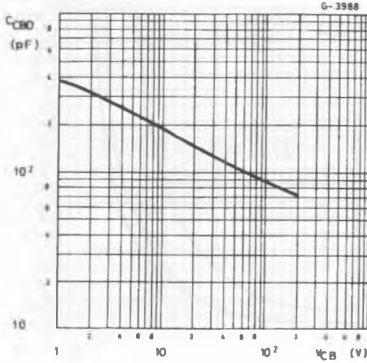
Saturated Switching Characteristics.



Transition Frequency.



Collector-base Capacitance.



Clamped Reverse Bias Safe Operating Areas.

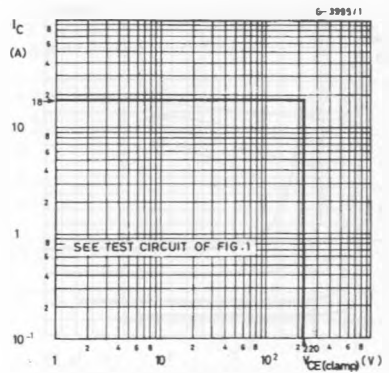


Figure 1 : Clamped  $E_{S/b}$  Test Circuit.

Figure 2 : Switching Times Test Circuit (resistive load).

